

Development of μ -PIC at Kyoto

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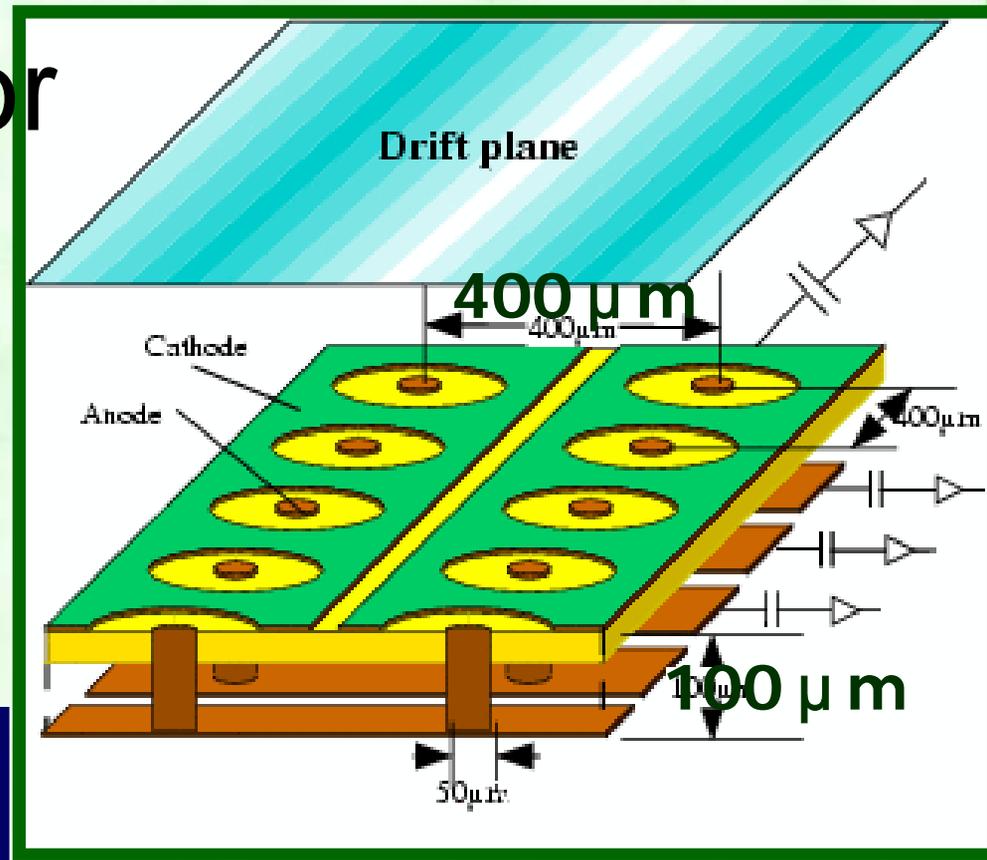
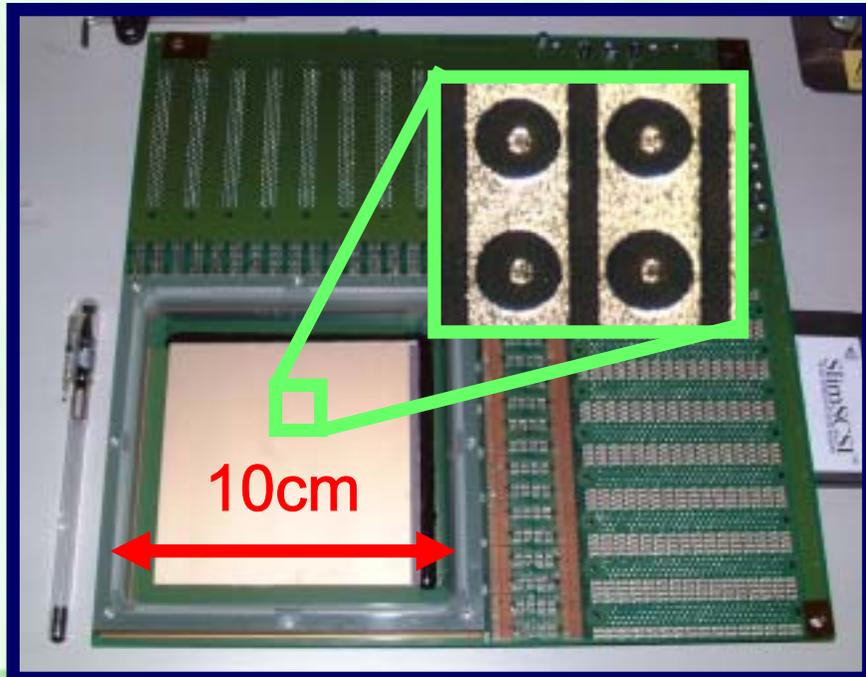
2003 March 19th @EVTEK, Espoo, Finland

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1. μ -PIC Detector

- ◆ **Micro Pixel Chamber**
- ◆ 2-D imaging detector for charged particles
- ◆ manufactured by the PCB technology

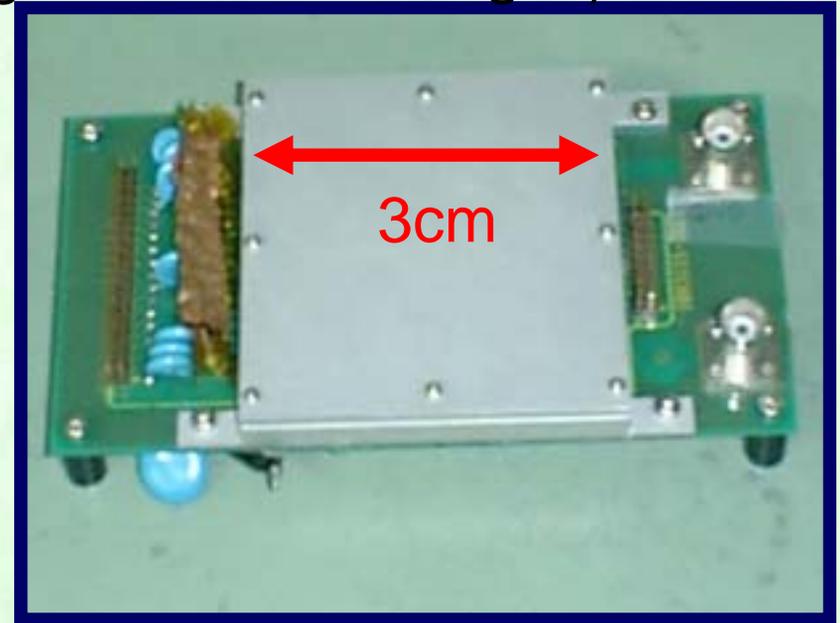


- ◆ 10cm \times 10cm μ -PIC
- ◆ 256 anode + 256 cathode strips
- ◆ Fine position resolution
- ◆ High gain
- ◆ Discharge damage: small

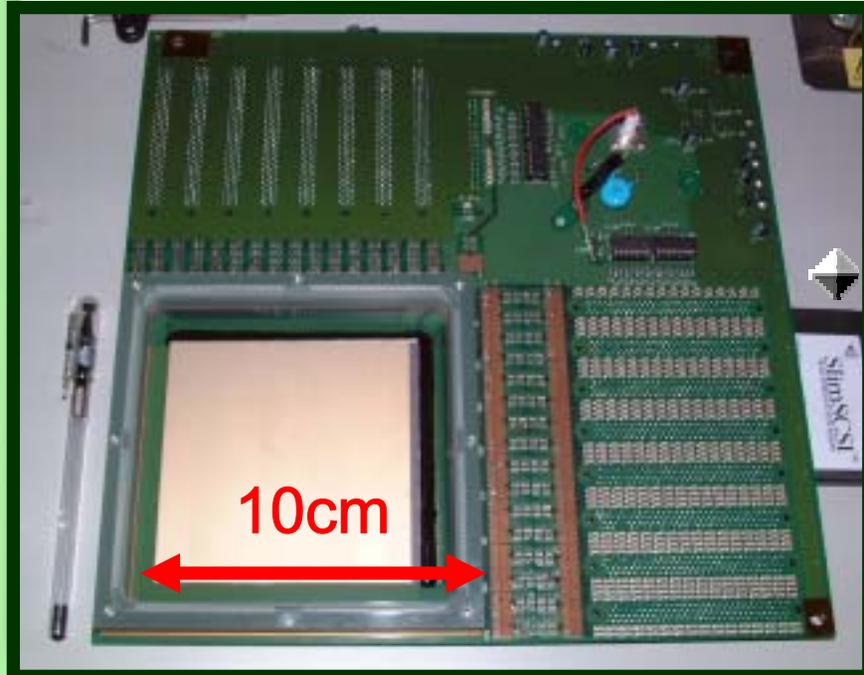
2. Development History

(History of the fight against the discharges)

- ◆ **Test Piece ($3 \times 3\text{cm}^2$)**
 - several pieces up to now
 - ~\$5,000 /pc
 - for “trials”
(material, technology, ...)



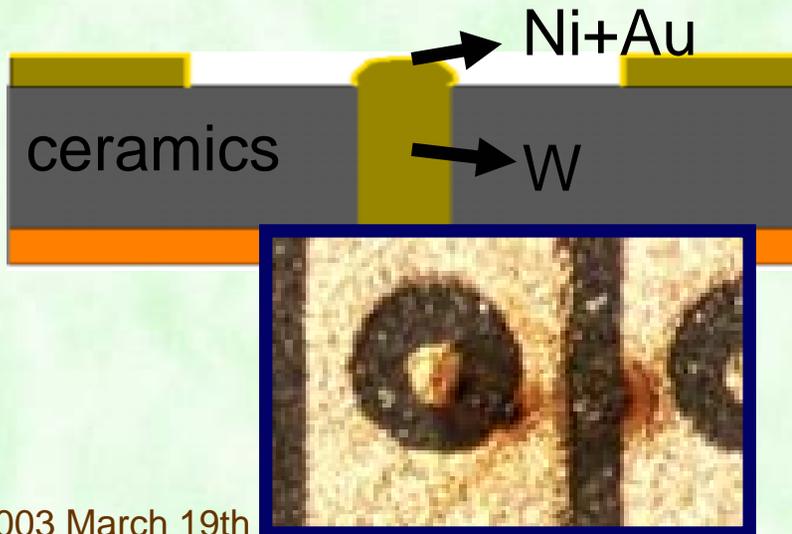
- ◆ **Full size detector ($10 \times 10\text{cm}^2$)**
 - 5 detectors up to now
 - ~\$30,000/pc
(including the motherboard.)



Development of the Full size detectors

- started in 2000
- Made by Toshiba

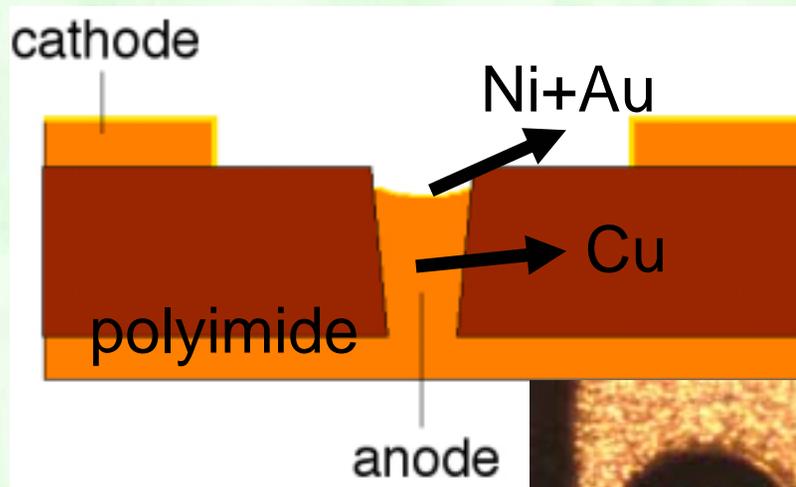
Detector	Substrate	Electrode	Anode height
μ -PIC 1	ceramics	W, Ni, Au	+10 μm
μ -PIC 2	polyimide	Cu, Ni, Au	-25 μm
μ -PIC 3	polyimide	Cu, Ni, Au	-15 μm
μ -PIC 4,5	polyimide	Cu, Ni	-20 μm



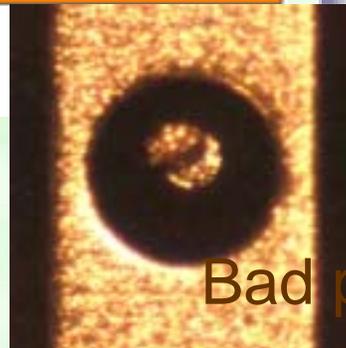
- Manufacturing: easy (uniform anode electrodes)
- Ceramics: Catalytic discharge \rightarrow **conductive**
- not for practical use

Development of the Full size detectors

Detector	Substrate	Electrode	Anode height
μ -PIC 1	ceramics	W, Ni, Au	+10 μm
μ -PIC 2	polyimide	Cu, Ni, Au	-40 μm
μ -PIC 3	polyimide	Cu, Ni, Au	-15 μm
μ -PIC 4,5	polyimide	Cu, Ni	-20 μm



- Polyimide base: better
- μ -PIC 2: low gain (<3000)
- μ -PIC 3: higher gain (~7000)
- Gold plating: scatters around discharge \rightarrow **conductive**

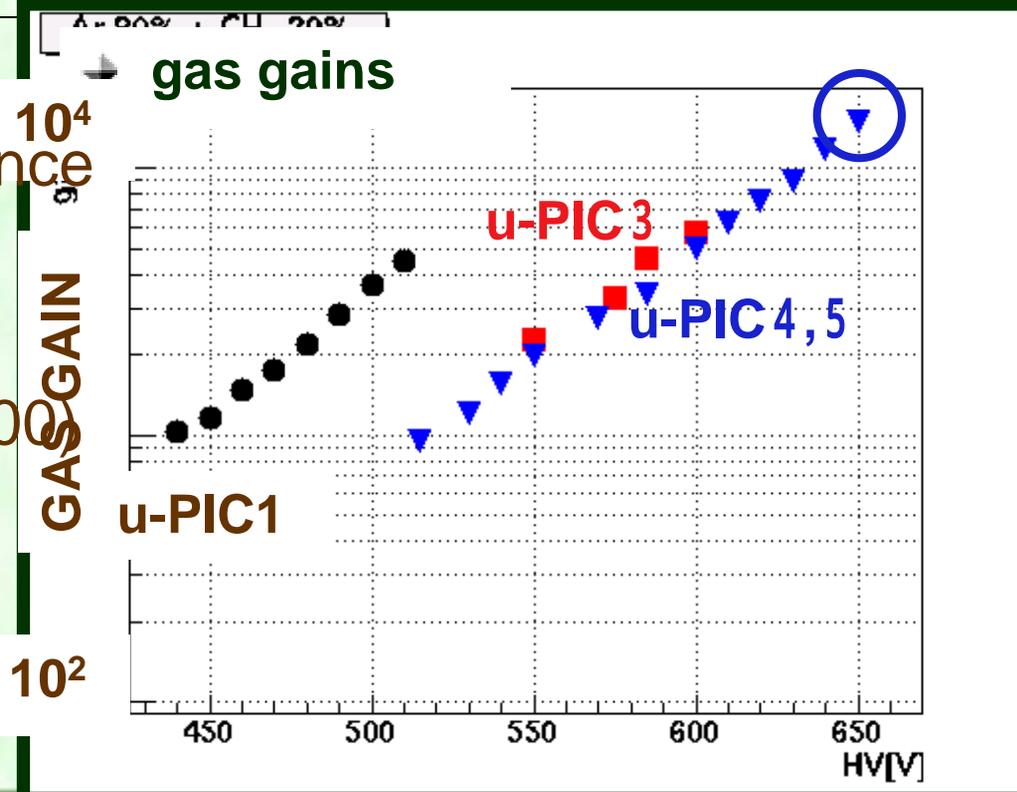


Bad pixel found in μ -PIC 3

Development of the Full size detectors

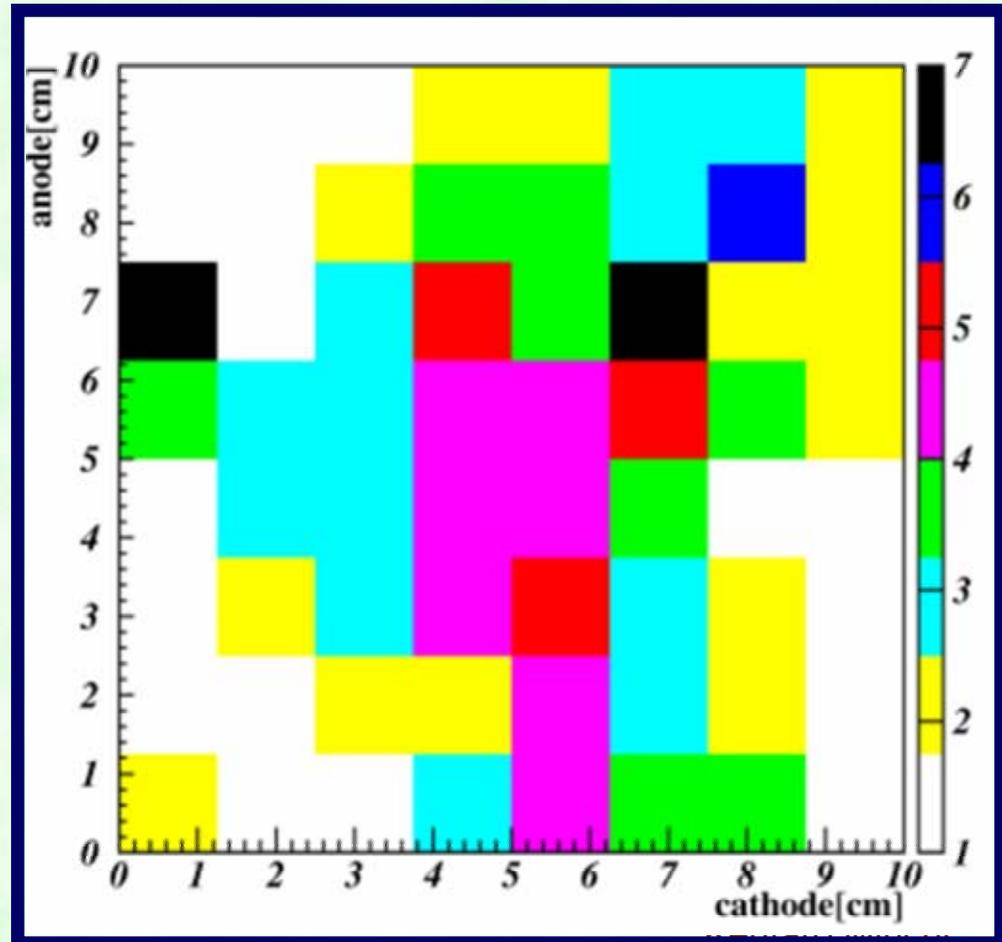
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μ -PIC 4,5	polyimide	Cu, Ni	-20 μm

- μ -PIC 4,5: good performance
- high gain (~ 15000)
- stable operation
(1000 hours with gain 3000)



Development of the Full size detectors

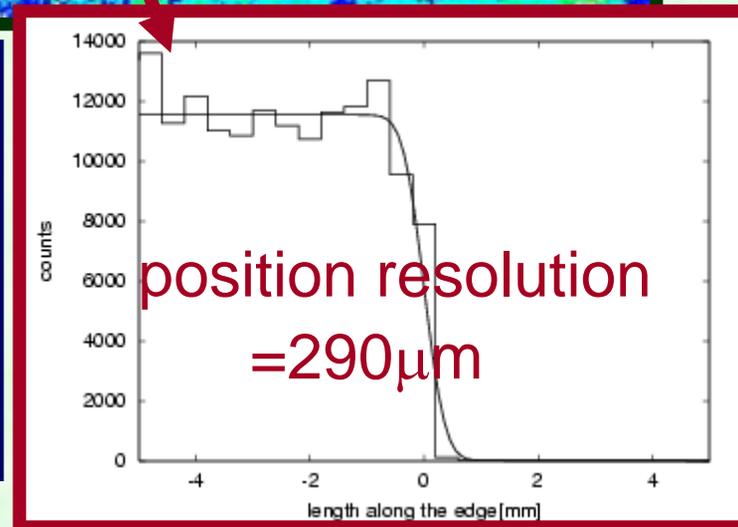
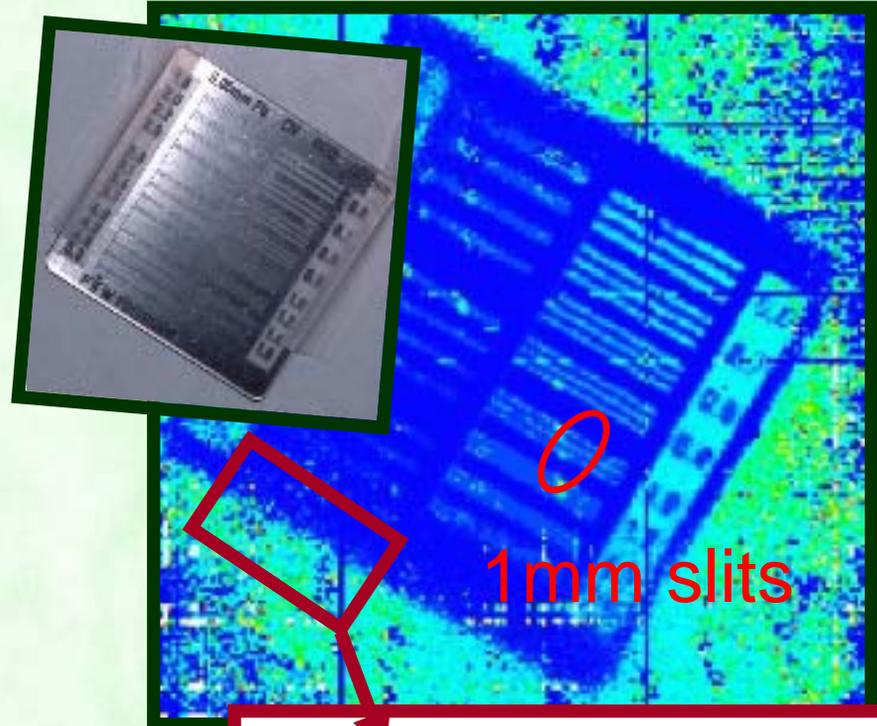
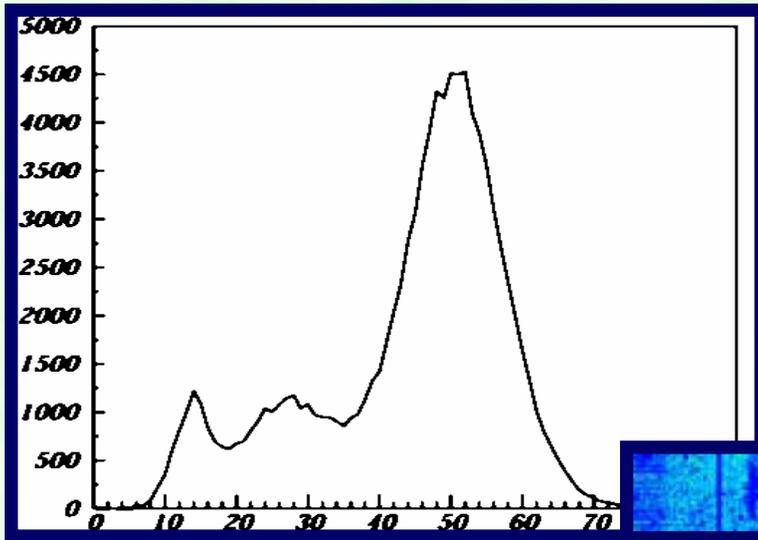
- μ -PIC 4,5: problems to be solved
anode electrodes heights are not uniform
- large vessel for the plating was prepared
- μ -PIC 6 will be shipped
at the end of March



3. Current Status (μ -PIC 4,5) \blacktriangleleft Imaging

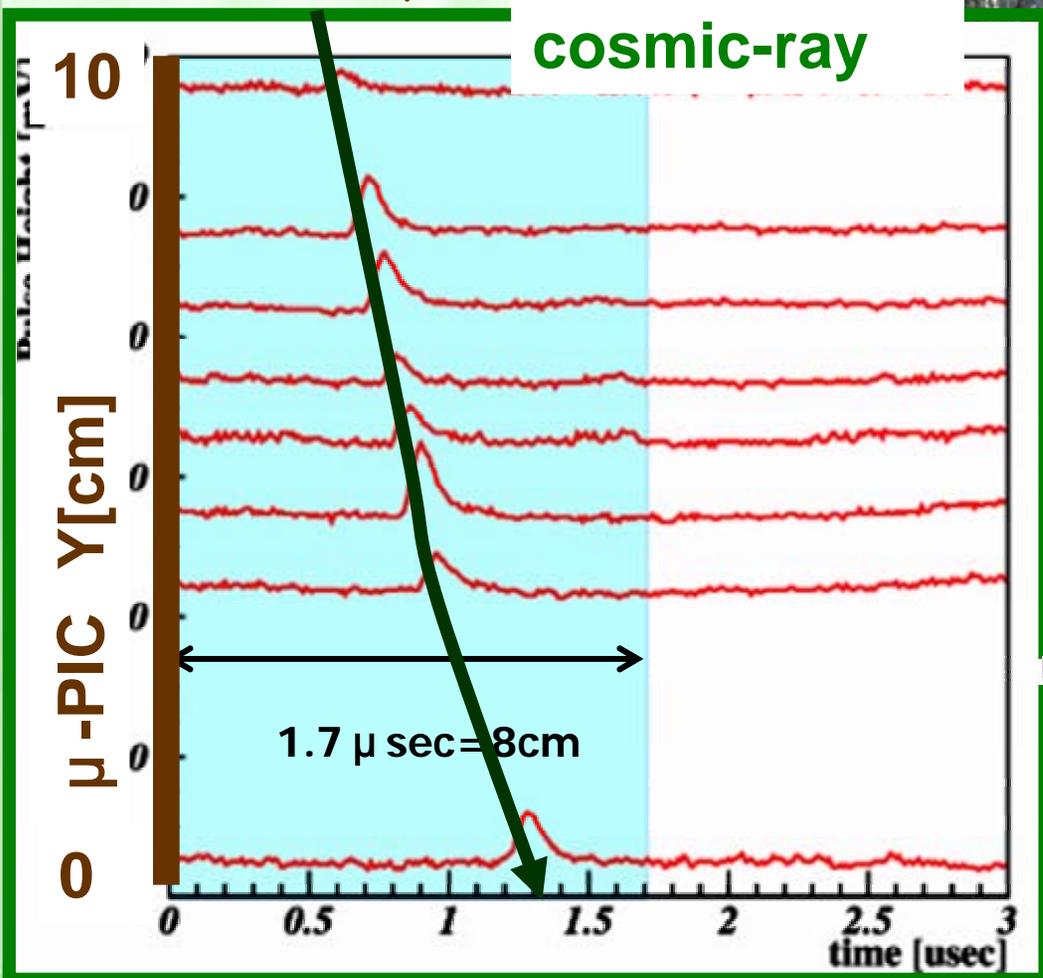
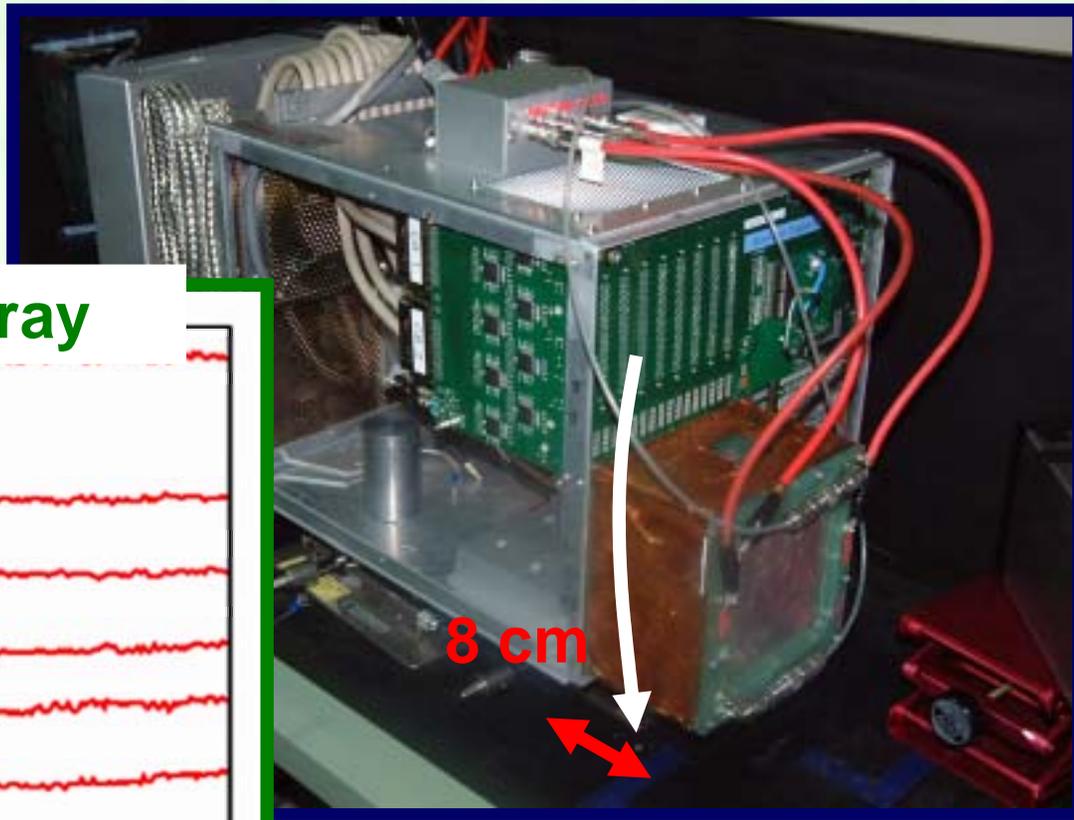
\blacktriangleleft Spectrometry

- energy resolution
FWHM30% @ 5.9keV



◆ μ -PIC for Micro-TPC

- drift enclosure
8cm drift length
4.7cm/ μ s drift V

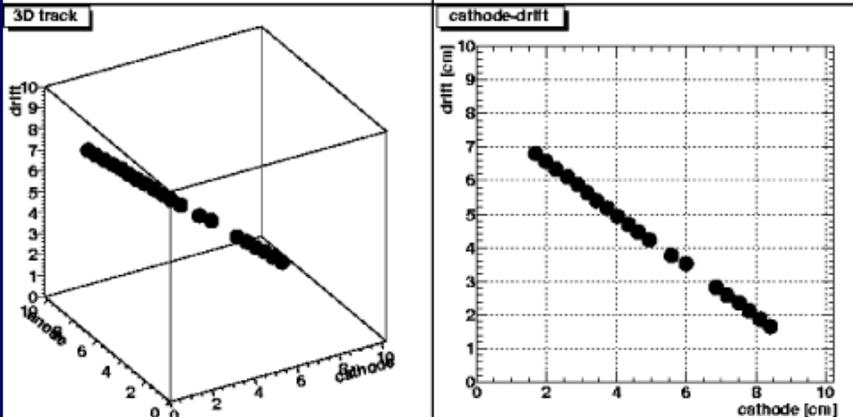
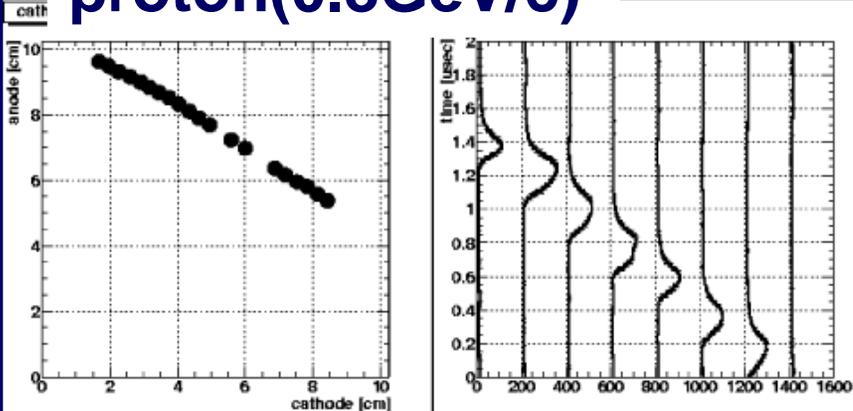


- micro-TPC
X,Y information : μ -PIC
Z information: timing

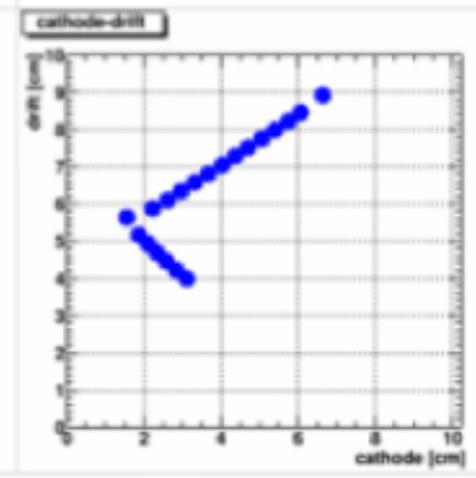
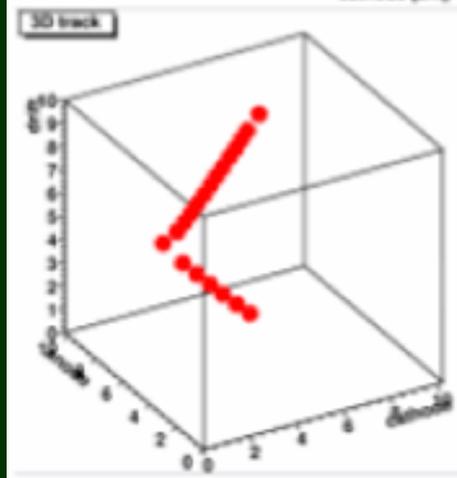
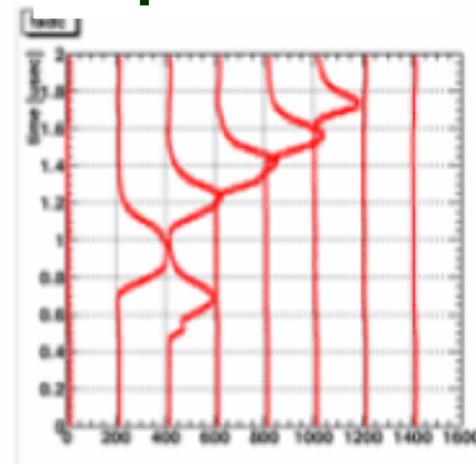
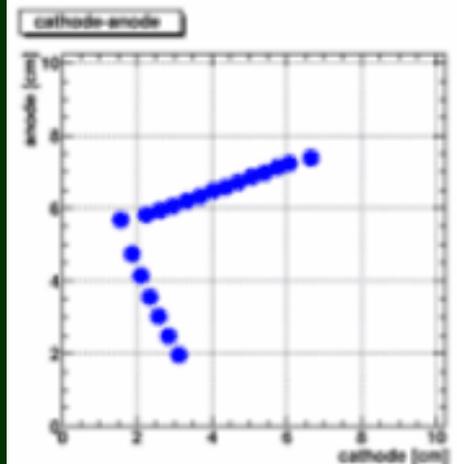
● tracking the charged particles

@proton synchrotron(gain~3000)

proton(0.8GeV/c)



particle?

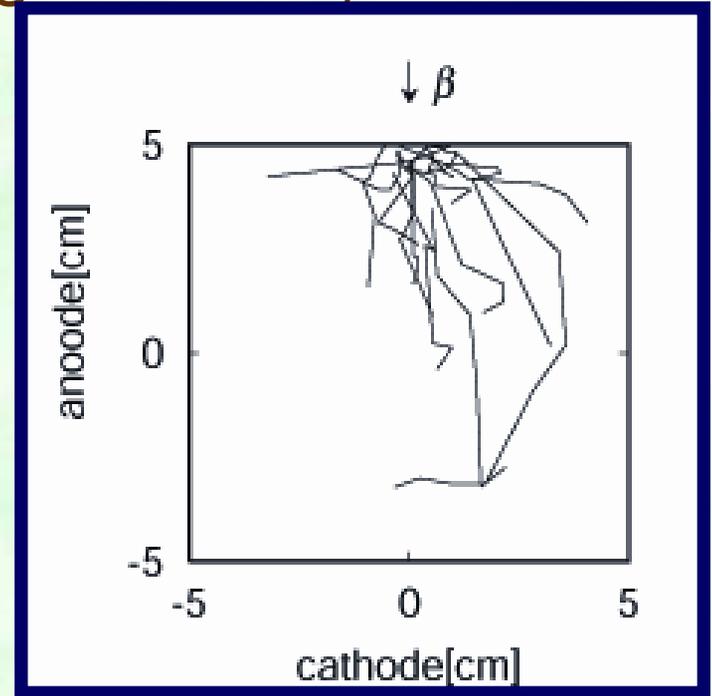
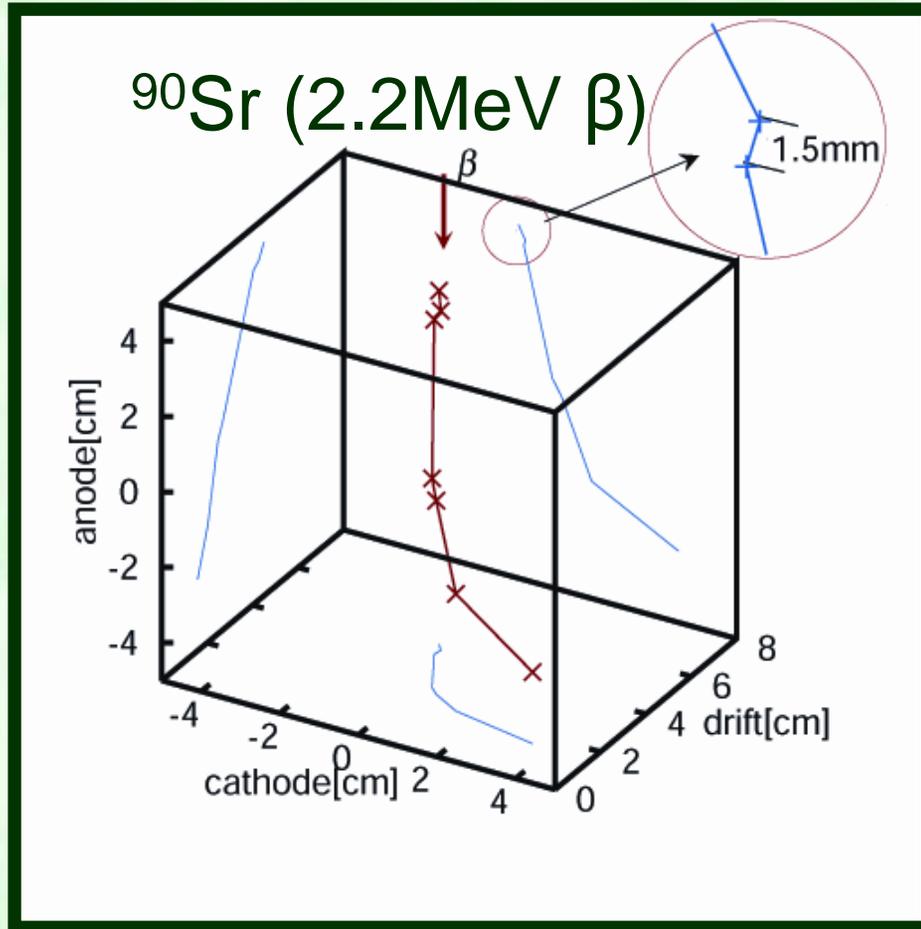


good tracking ability

for large dE/dx particles

● tracking the charged particles

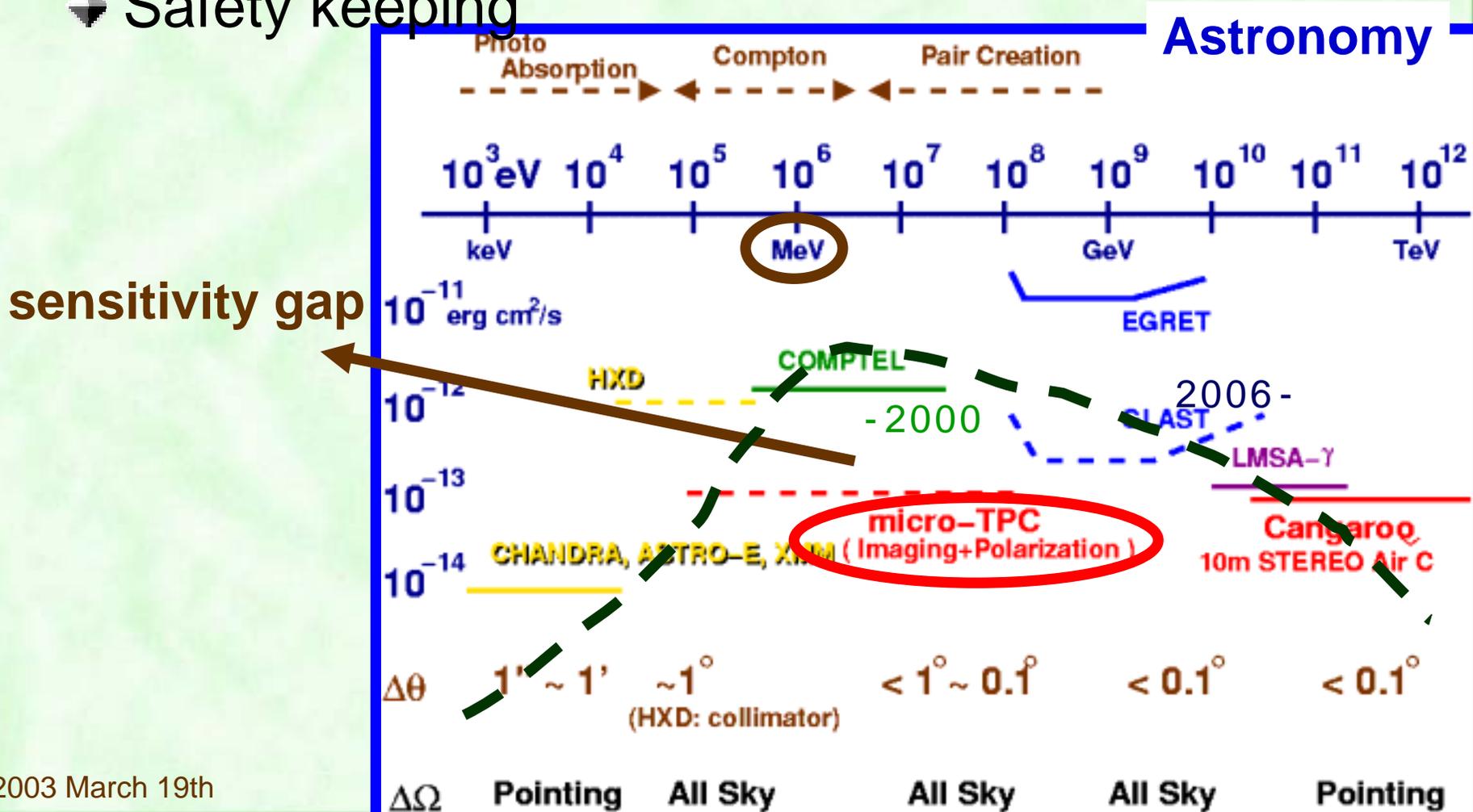
@laboratory (gain~7000)



not enough...
more gain

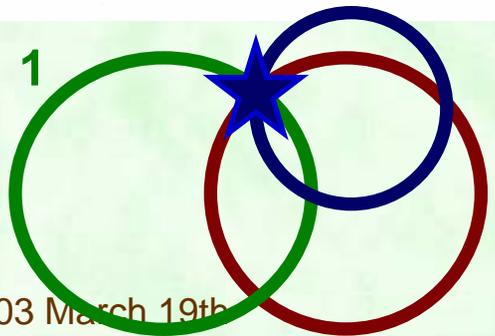
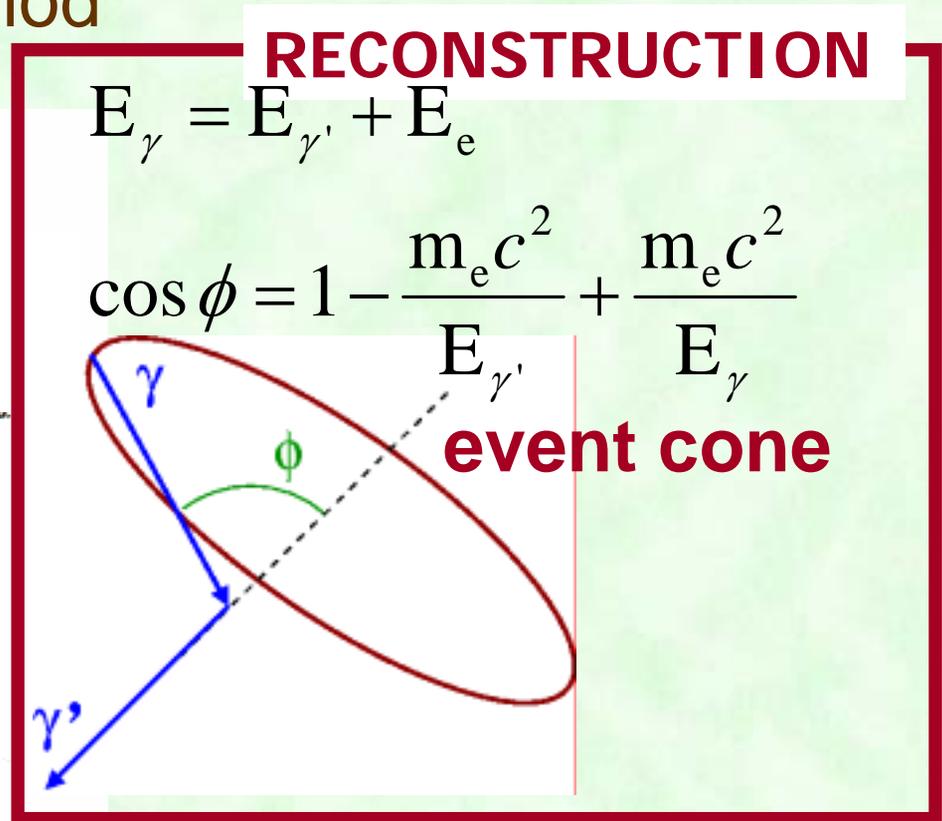
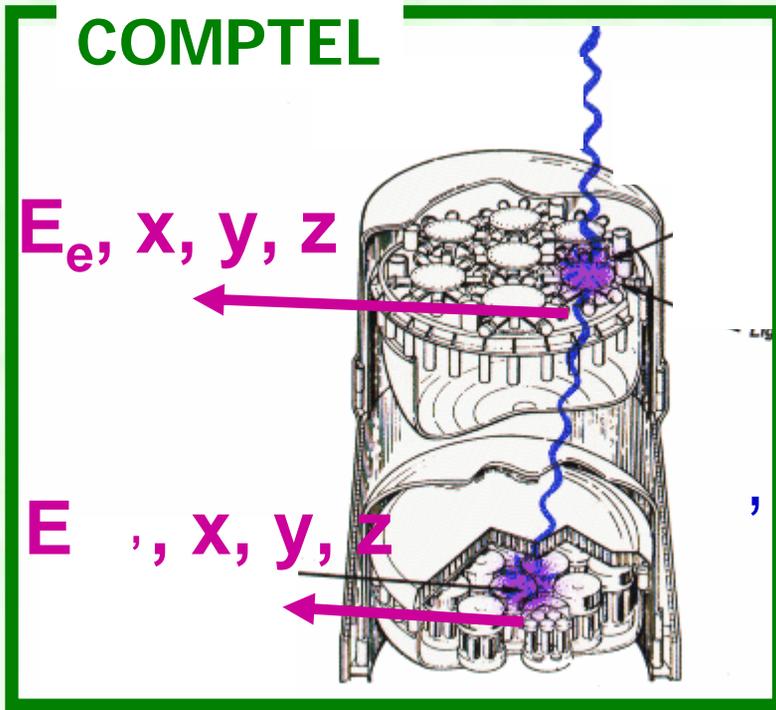
MeV gamma-ray imaging

- ◆ Astronomy
- ◆ Medical use
- ◆ Safety keeping



Compton -ray Imaging

Double Compton Method

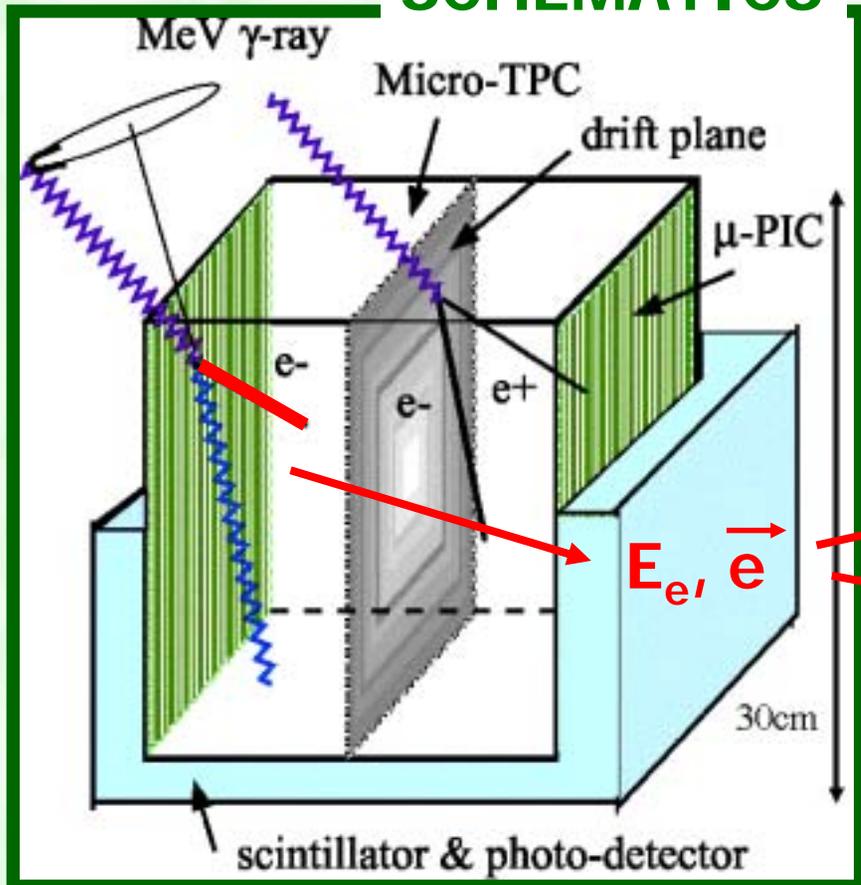


- 1 ✓ 3 1 direction
- 2 ✓ 3 No background rejection
- 3 ✓ 2 needs TOF to know UP or DOWN

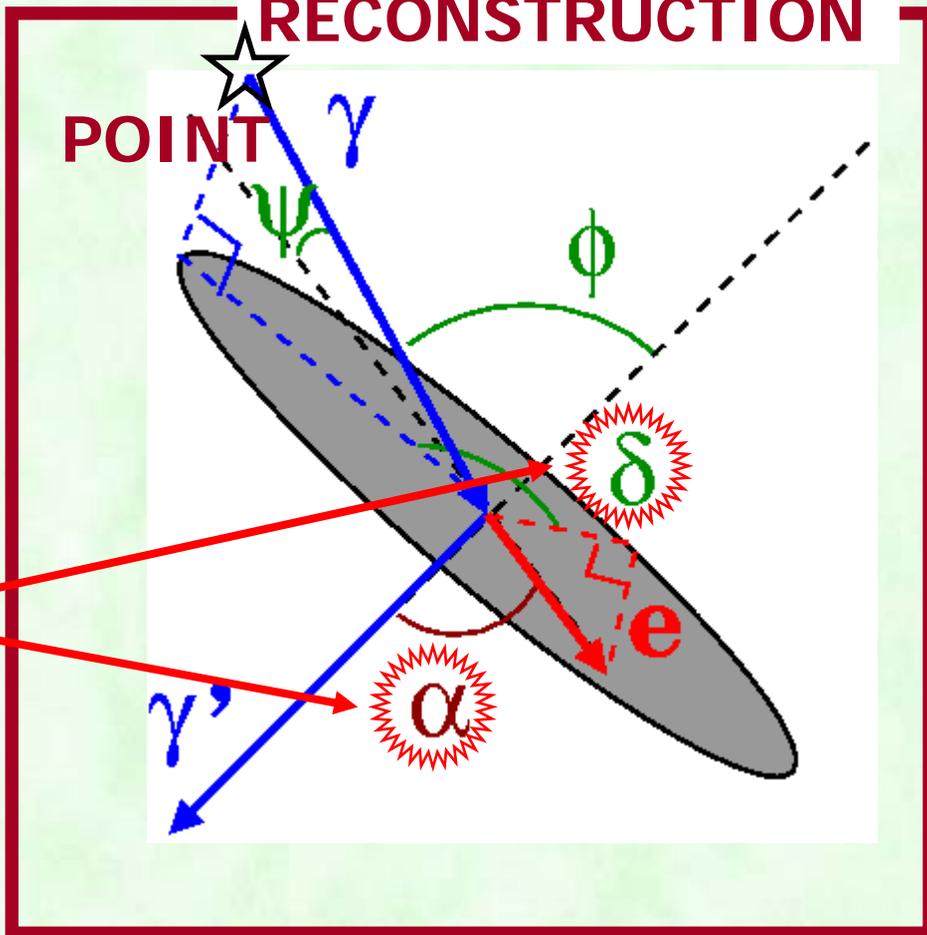
Our method Method

C

SCHEMATICS



RECONSTRUCTION



BG rejection

Kentaro Miuchi

● -ray imaging with micro-TPC

electron track: micro-TPC

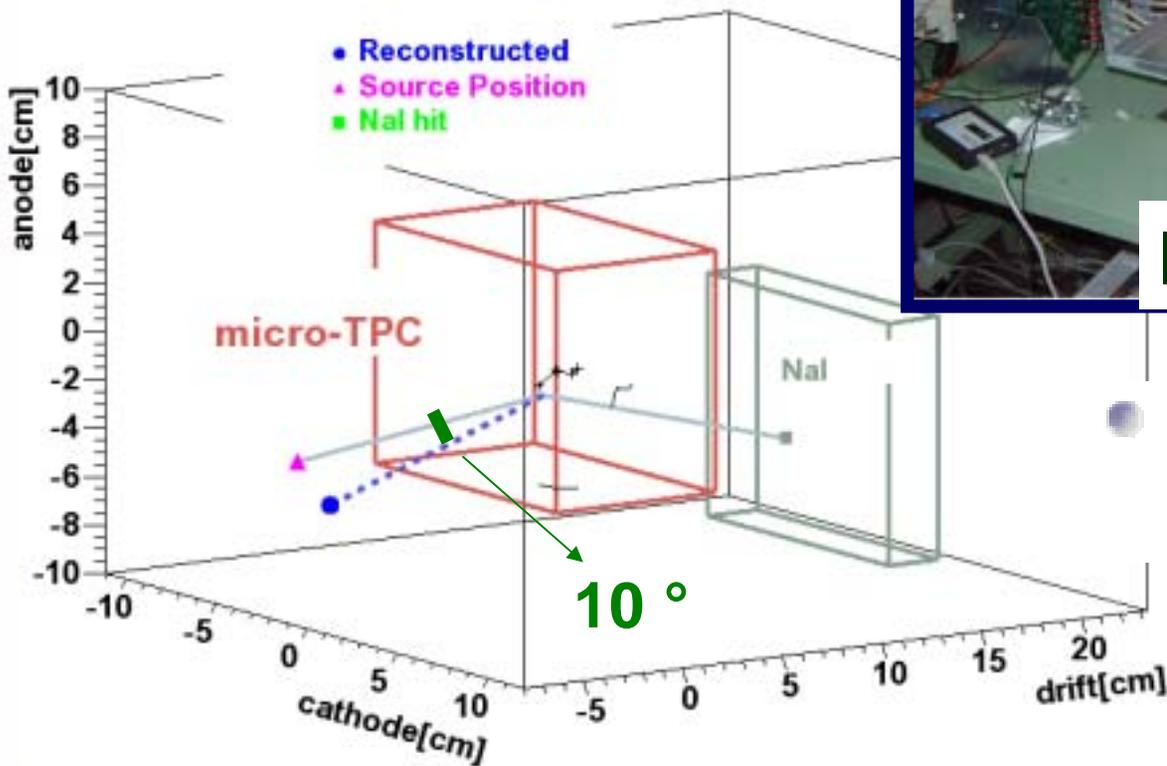
+

scattered : NaI(Tl) scintillator



FULL RECONSTRUCTION

typical event



prototype

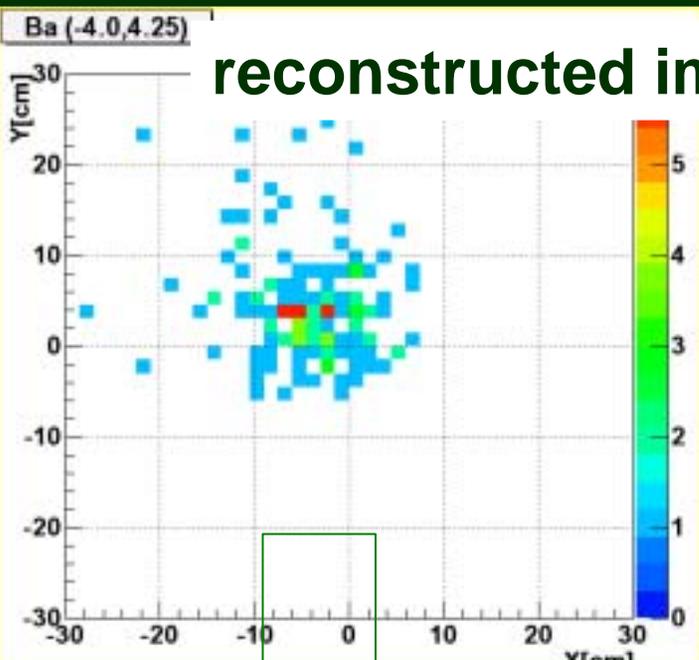
^{133}Ba (356keV)

NaI

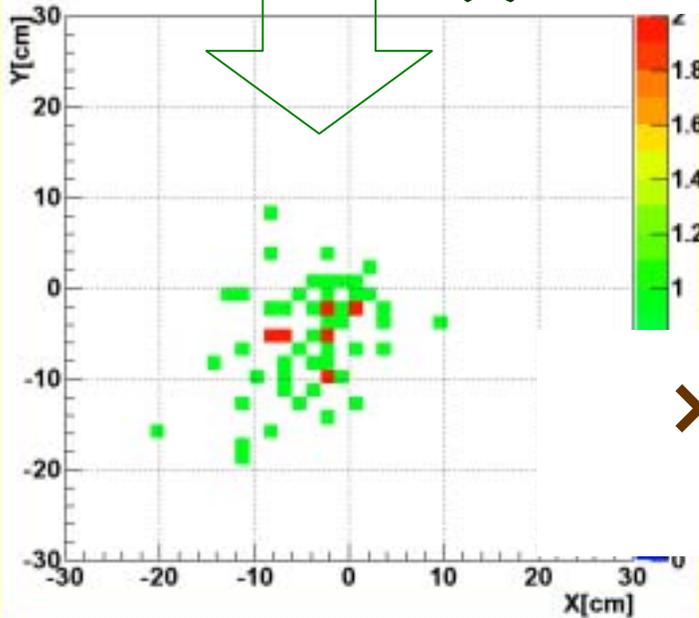
Micro-TPC

● IT WORKS!!
(for the first time in
the world)

reconstructed images



source -8cm(Y)



- performance
angular resolution $\sim 40^\circ$
not enough...
more gain

Current status of μ -PIC

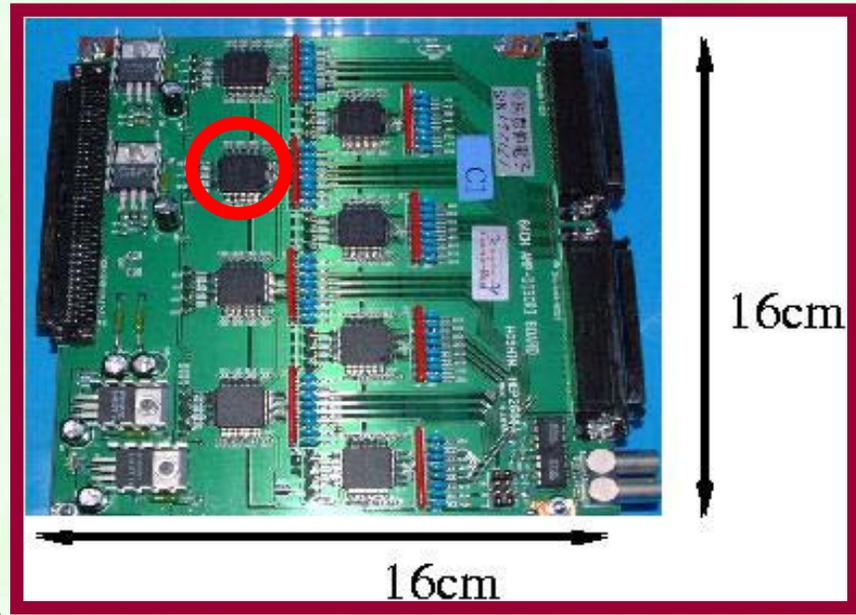
- X-ray: OK
- micro-TPC } not enough
- -ray imaging }

$\times 10$ improvement for
minimum ionizing particles

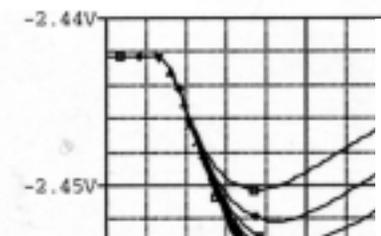
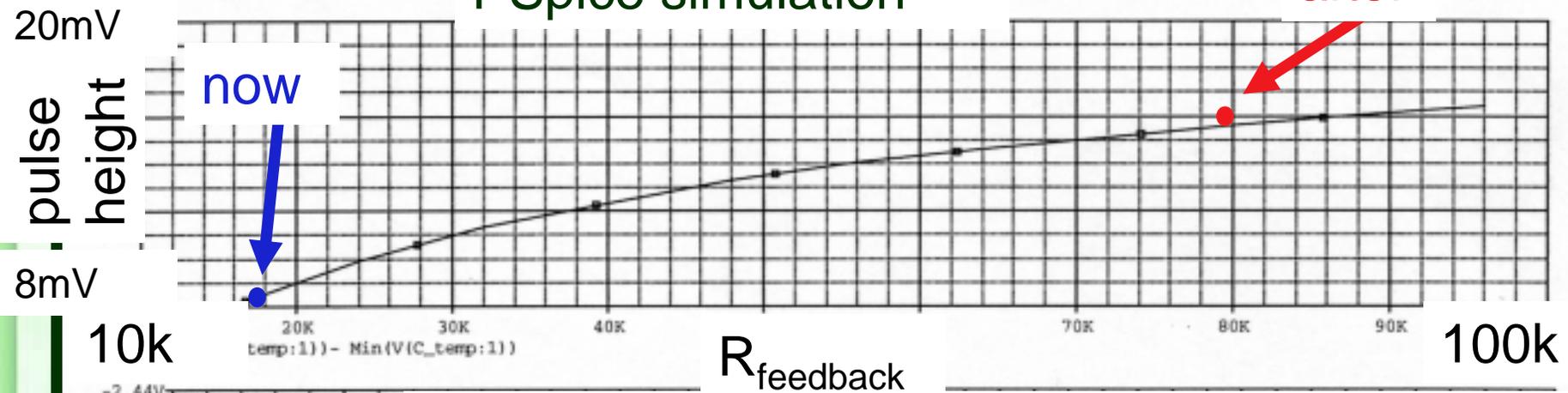
4. Future Works

Amplifier modifications

- SONY semi-custom IC
- ASD (amplifier-shaper-discriminator) chip
- shaping time 16ns->80ns



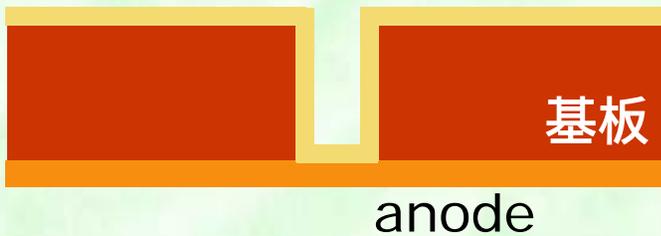
PSpice simulation



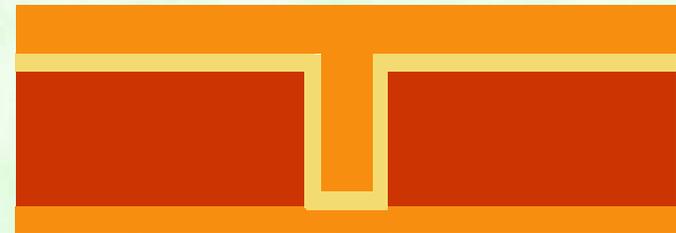
- test chip is shipped in March 20th
- pulse height $\times 2$ expected

◆ New plating technology (for μ -PIC 7+, hopefully)

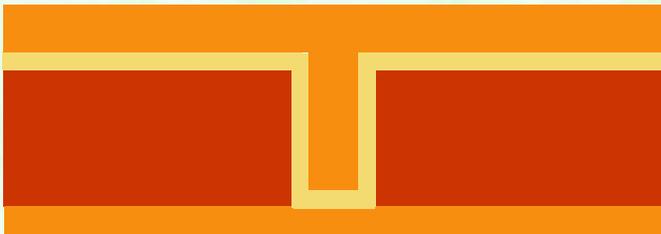
1. Electroless plating



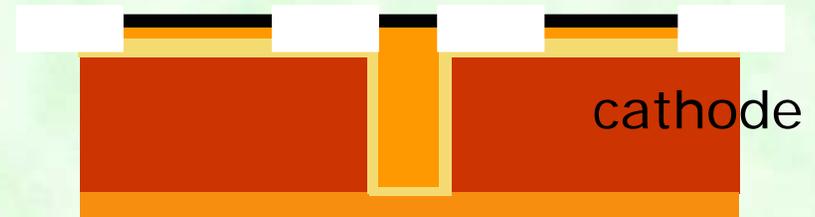
3. Surface etching



2. Via-fill plating



4. Electrode etching



High and uniform anode electrodes will be made.

◆ Geometry studies

- Simulation work at Kyoto (Maxwell + Garfield)

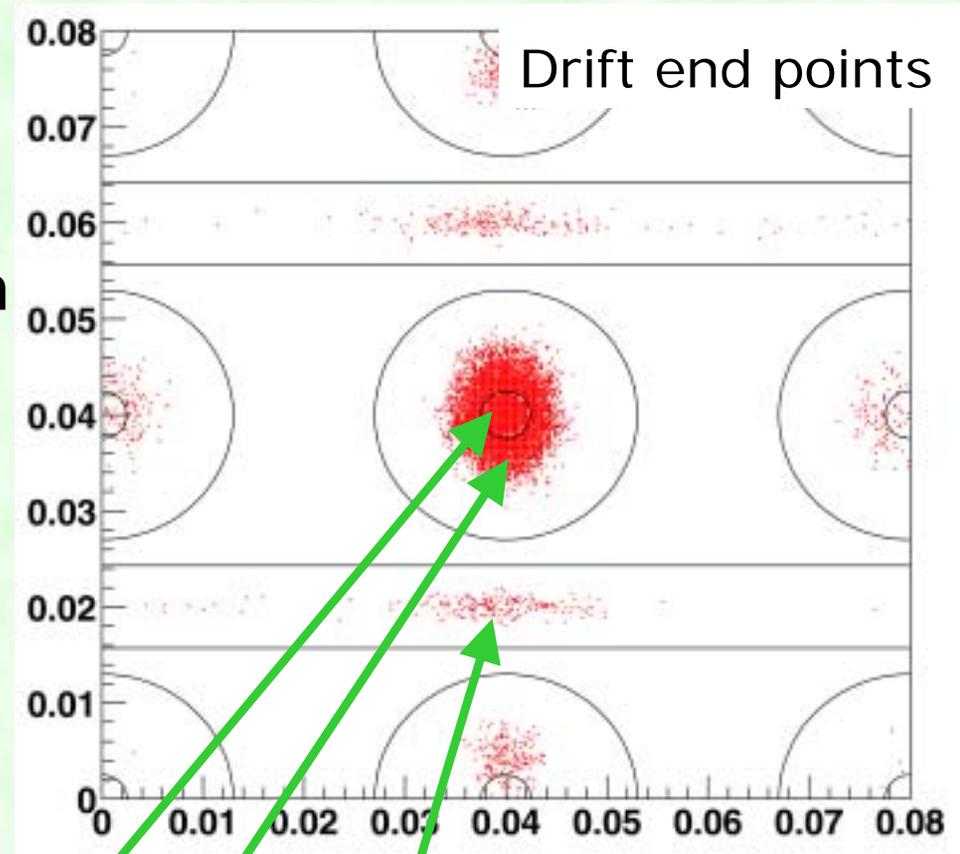
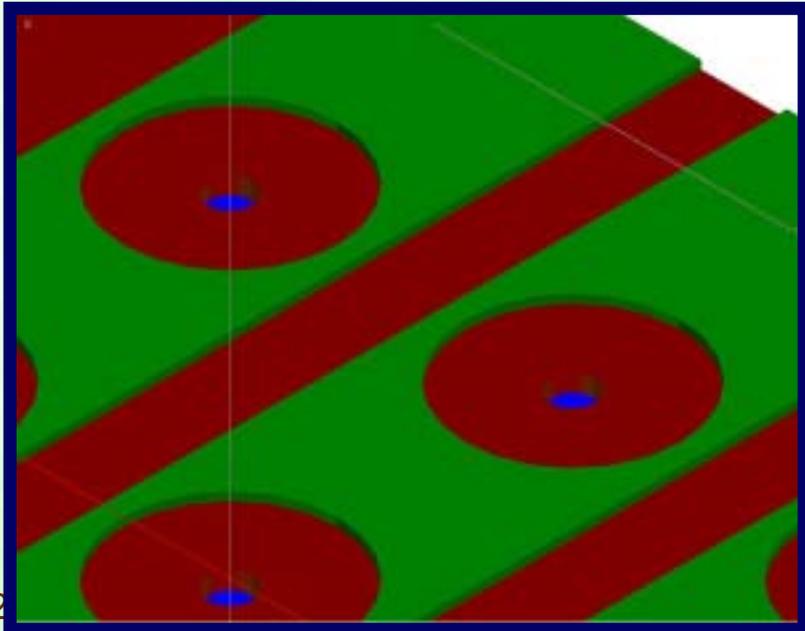
- μ -PIC4,5

Cathode width: 314 μ m

Cathode diameter: 260 μ m

Anode height: -20 μ m

Anode diameter: 50 μ m



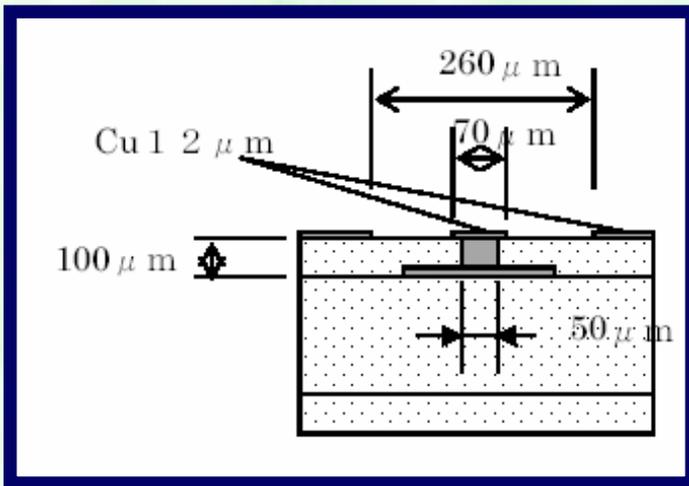
Collection efficiency ... 30%

Near pin ... 65%

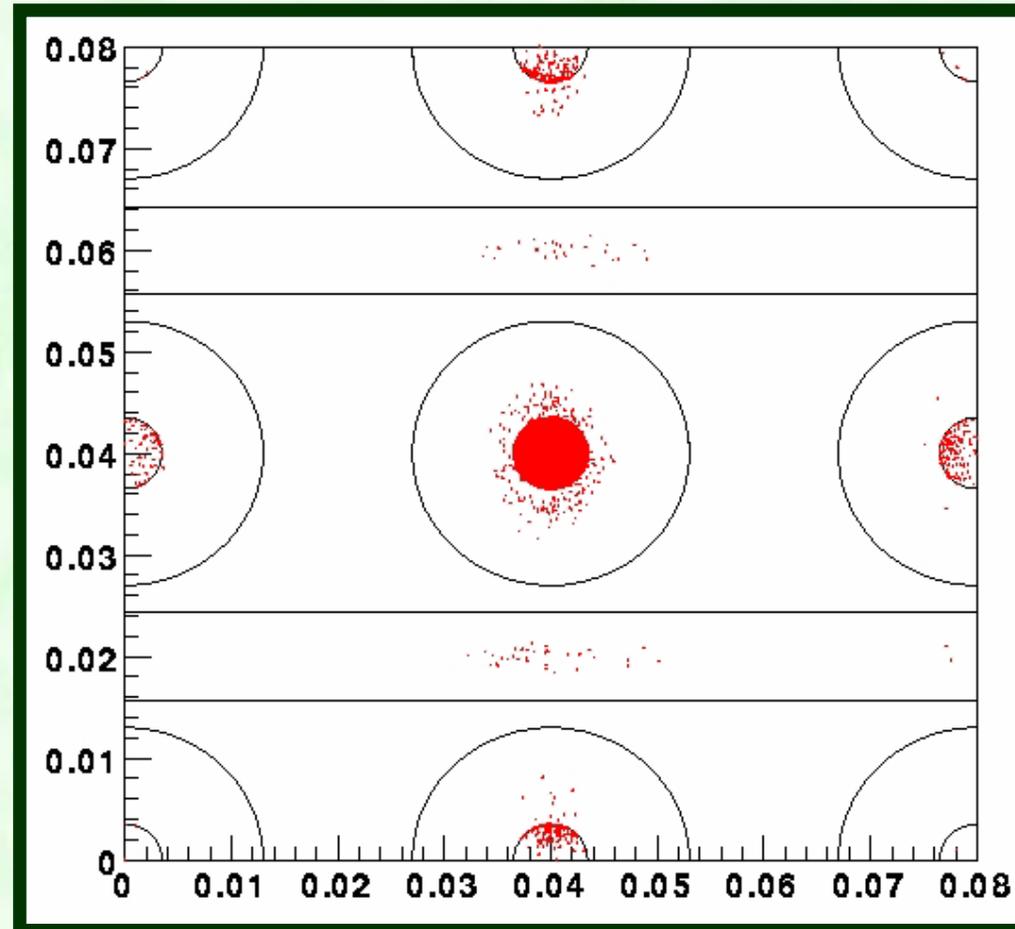
Cathode gap ... 4%

◆ μ -PIC7 (with new plating technology)

- Cathode width: $314\mu\text{m}$
- Hole diameter: $260\mu\text{m}$
- Anode height: $10\mu\text{m}$
- Anode diameter: $70\mu\text{m}$

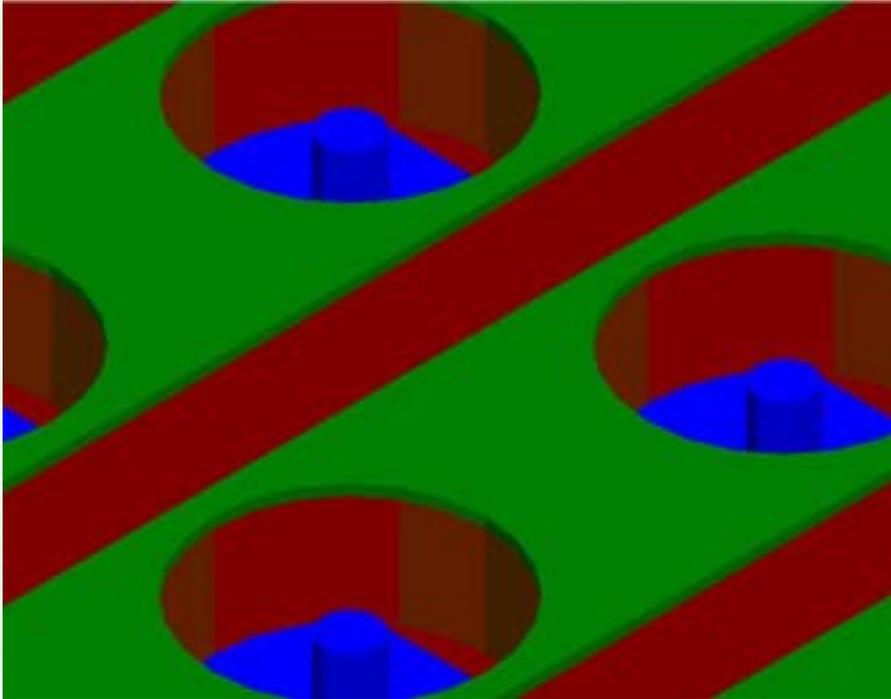


Collection ... 97%
Near pin ... 2%
Gap ... <1%



High efficiency
is expected!!

Well type μ -PIC



Manufacturing process

cathode



anode

Advantages

No near pin electrons
No discharge?

3cm test piece with laser machining
--> discharge problem

• Technology breakthrough is expected (RIE process?)

• Energy resolutions?

5. Summary

◆ Development History

- five full-size μ -PIC
- Polyimide base + no gold plating

◆ Current Status

- X-ray 2-D imaging detector
- Micro-TPC
- Gamma-ray imaging

◆ Future Works

- new plating technology
- well type μ -PIC